Power MOSFET 30 V, 16 A, N-Channel, SO-8

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Points of Loads
- Power Load Switch
- Motor Controls

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady			13	Α
Current R _{0JA} (Note 1)	State	T _A = 70°C		10.4	1
Power Dissipation $R_{\theta JA}$ (Note 1)	Steady State	$T_A = 25^{\circ}C$	P _D	1.38	W
Continuous Drain	Steady	T _A = 25°C	Ι _D	10	А
Current R _{θJA} (Note 2)	State	T _A = 70°C		8.0	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P _D	0.81	W
Continuous Drain	Steady	T _A = 25°C	I _D	16	А
Current $R_{\theta JA}$, t \leq 10 s (Note 1)	State	$T_A = 70^{\circ}C$		12.7	
$\begin{array}{l} \text{Power Dissipation} \\ R_{\theta JA}, t \leq 10 \; s(\text{Note 1}) \end{array}$	Steady State	T _A = 25°C	PD	2.1	W
Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \mu s$			I _{DM}	126	А
Operating Junction and S	Т _Ј , T _{stg}	–55 to 150	°C		
Source Current (Body Die	۱ _S	2.1	А		
	E _{AS}	128	mJ		
Lead Temperature for So (1/8" from case for 10 s)	ΤL	260	°C		

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	91.9	°C/W
Junction-to-Ambient $-t \le 10 \text{ s}$ (Note 1)	$R_{\theta JA}$	60.4	
Junction-to-Foot (Drain)	$R_{\theta JF}$	21.6	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	154	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surfacemounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

2. Surfacemounted on FR4 board using the minimum recommended pad size.

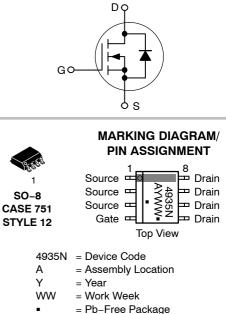


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
30 V	5.1 m Ω @ 10 V	16 A	
30 V	7.0 mΩ @ 4.5 V	IUA	





(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS4935NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.



Parameter	Symbol	Test Condition	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		4
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				13.4		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		$T_J = 25^{\circ}C$			1.0	μΑ
		V_{GS} = 0 V, V_{DS} = 24 V	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =			1	±100	nA
ON CHARACTERISTICS (Note 3)	1					1	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μA	1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	7.5 A		4.2	5.1	mΩ
		V _{GS} = 4.5 V, I _D =	6.5 A		5.3	7.0	1
Forward Transconductance	9 FS	V _{DS} = 1.5 V, I _D =	7.5 A		28		S
CHARGES, CAPACITANCES AND GA		ICE			•		4
Input Capacitance	C _{iss}				3639		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz,	, V _{DS} = 25 V		971		-
Reverse Transfer Capacitance	C _{rss}	-			31		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 7.5 A			23.3		nC
Threshold Gate Charge	Q _{G(TH)}				6.2		-
Gate-to-Source Charge	Q _{GS}				9.7		
Gate-to-Drain Charge	Q _{GD}				3.8		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 7.5 A			52.1		nC
SWITCHING CHARACTERISTICS (No	. ,	1					
Turn-On Delay Time	t _{d(on)}				14	1	ns
Rise Time	t _r		- 15 \/		3.7		
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 1.0 A, R _G = 6.0 Ω			60		
Fall Time	t _f				40.2		
DRAIN-SOURCE DIODE CHARACTE					1		I
Forward Diode Voltage	V _{SD}		T _J = 25°C		0.72	1.0	V
, and the second s	02	V_{GS} = 0 V, I _S = 2.0 A	с Т _Ј = 125°С		0.55		
Reverse Recovery Time	t _{RR}		3		47.3		ns
Charge Time	t _a	V_{GS} = 0 V, d_{IS}/d_t = 100 A/µs, I_S = 2.0 A			23.3		
Discharge Time	t _b				24		
Reverse Recovery Charge	Q _{RR}				57		nC
PACKAGE PARASITIC VALUES	'nn	1			1	1	1
Source Inductance	L _S				0.66		nH
Drain Inductance	L _D	- T _A = 25°C			0.2		-
Gate Inductance	L _G				1.5		
Gate Resistance	R _G				0.5	1.0	Ω

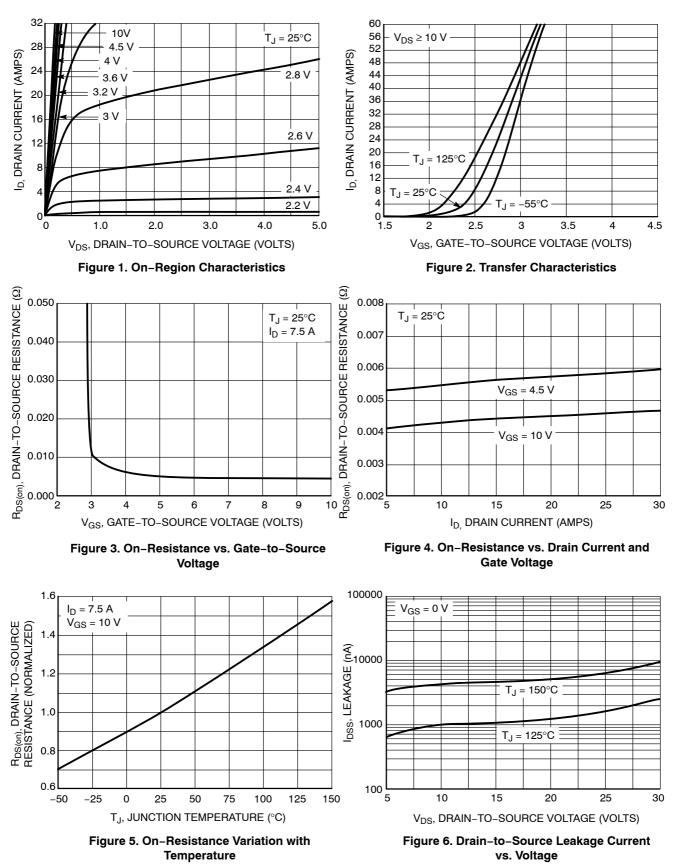
 Gate Resistance
 R_G

 3. Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.

 4. Switching characteristics are independent of operating junction temperatures.

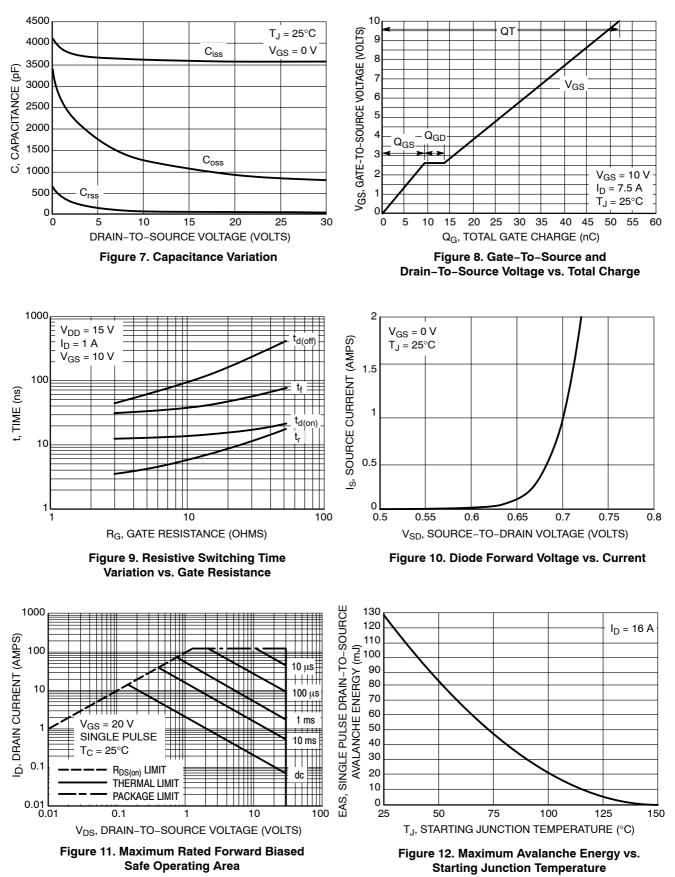
TYPICAL PERFORMANCE CURVES

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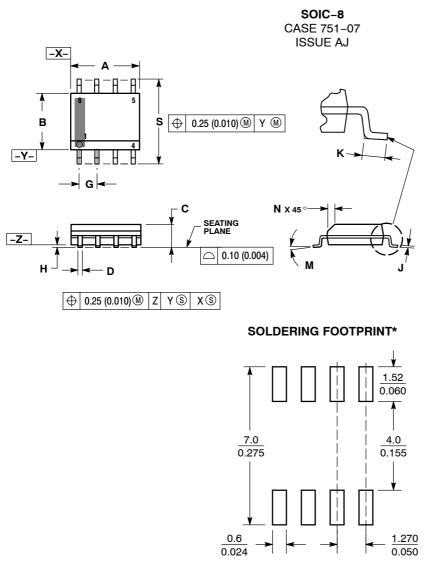


TYPICAL PERFORMANCE CURVES

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PACKAGE DIMENSIONS



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION. 2 З.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4. PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR 5. PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION. 6

υ.	751-01 THING 751-00 ARE OBSOLETE. NEW
	STANDARD IS 751-07.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
κ	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
Ν	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

TYLE 1	2:
PIN 1.	SOURCE
2.	SOURCE
3.	SOURCE
4.	GATE
5.	DRAIN
6.	DRAIN
7.	DRAIN

S

(mm inches

SCALE 6:1

8. DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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